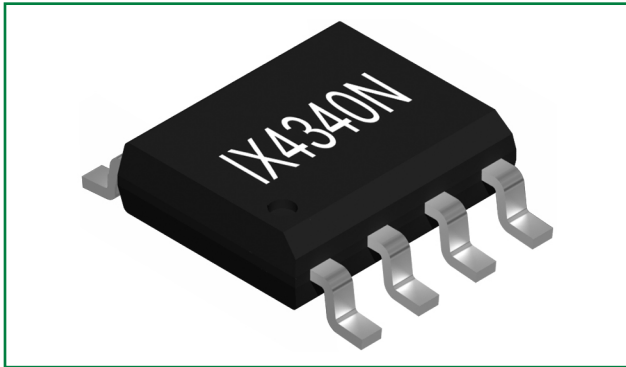


IX4340

5-Ampere, Dual Low-Side MOSFET Driver



Description

The IX4340 is a dual, high current, low-side gate driver. Each of the two outputs is capable of sourcing and sinking 5A of peak current, and has a maximum voltage rating of 20V. The two outputs can be paralleled for higher current applications. Fast propagation delay times (16ns typical) and fast rise and fall times (7ns) make the IX4340 well suited for high frequency applications.

The inputs are TTL and CMOS logic compatible, and there is an independent Enable function for each output. Under voltage lockout circuitry (UVLO) prevents the high side source driver from conducting until there is sufficient supply voltage. The outputs are held low if the logic inputs are floating.

The IX4340 is available in a standard 8-pin SOIC and thermally enhanced 8-pin SOIC and MSOP packages.

Features

- Two Independent Drivers, Each Capable of Sourcing and Sinking 5A
- CMOS and TTL Compatible Inputs
- Independent Enable for Each Driver
- 5V to 18V Supply Voltage Range
- -40°C to +125°C Extended Operating Temperature Range
- ±4kV ESD Rating (Human Body Model)
- Thermally Enhanced 8-pin SOIC and MSOP Packages, and Standard 8-pin SOIC Package
- Under Voltage Lockout Circuitry
- Fast Propagation Delays (16ns typical)
- Fast Rise and Fall Times (7ns typical)

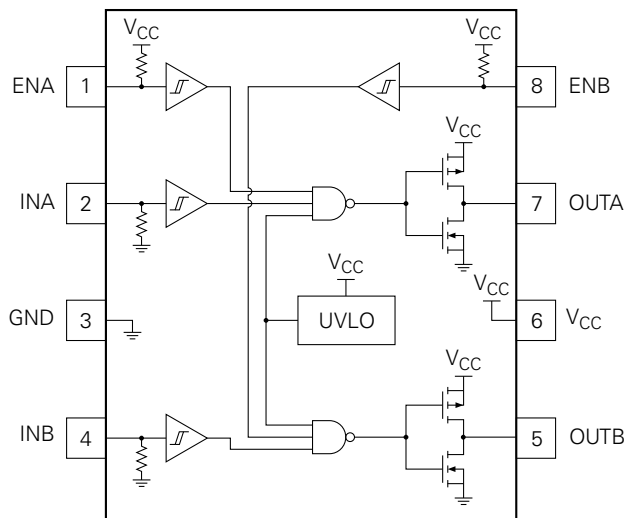
Applications

- Switch-Mode Power Supplies
- DC-DC Converters
- Motor Controllers
- Power Inverters

Ordering Information

| Part # | Description |
|------------|---|
| IX4340N | 8-Pin SOIC (100/Tube) |
| IX4340NTR | 8-Pin SOIC (4000/Reel) |
| IX4340NE | 8-Pin SOIC w/ Exposed Thermal Pad (100/Tube) |
| IX4340NETR | 8-Pin SOIC w/ Exposed Thermal Pad (4000/Reel) |
| IX4340UE | 8-Pin MSOP w/ Exposed Thermal Pad (80/Tube) |
| IX4340UETR | 8-Pin MSOP w/ Exposed Thermal Pad (5000/Reel) |

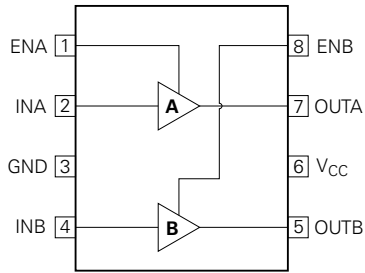
IX4340 Functional Block Diagram



| | | |
|----------|---|----|
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1 Specifications

1.1 Pin Configuration



1.2 Logic Table

| IN _x | EN _x | V _{CC} | OUT _x |
|-----------------|-----------------|--------------------------------------|------------------|
| 1 | 1 | V _{CC} > UVLO _{ON} | 1 |
| 0 | 1 | V _{CC} > UVLO _{ON} | 0 |
| x | 0 | V _{CC} > UVLO _{ON} | 0 |
| x | x | V _{CC} < UVLO _{ON} | 0 |

1.3 Pin Definitions

| Pin | Name | Description |
|-----|-----------------|---|
| 1 | ENA | Enable input for Channel A. A logic high (or floating) enables Channel A (the state of OUTA is determined by INA). A logic low disables OUTA (OUTA held low regardless of INA). |
| 2 | INA | Channel A logic input. Internally pulled to GND. |
| 3 | GND | Ground. Common ground reference for the device. |
| 4 | INB | Channel B logic input. Internally pulled to GND. |
| 5 | OUTB | Channel B output, capable of sourcing and sinking 5A. |
| 6 | V _{CC} | Supply voltage. |
| 7 | OUTA | Channel A output, capable of sourcing and sinking 5A. |
| 8 | ENB | Enable input for Channel B. A logic high (or floating) enables Channel B (the state of OUTB is determined by INB). A logic low disables OUTB (OUTB held low regardless of INB). |

The thermal pad on the bottom of the thermally enhanced devices, IX4340NE and IX4340UE, may be connected to GND or left floating; it must not be connected to any other net. The thermal pad is not intended to carry current.

1.4 Absolute Maximum Ratings

| Parameter | Symbol | Value | | Units |
|-------------------------------|------------------|---------|---------|-------|
| | | Minimum | Maximum | |
| Supply Voltage | V _{CC} | -0.3 | 20 | V |
| Input Voltage | V _{IN} | -0.3 | 20 | |
| Output Current | I _{OUT} | - | ±5 | A |
| ESD Rating (Human Body Model) | V _{ESD} | -4000 | +4000 | V |
| Junction Temperature | T _J | -55 | +150 | °C |
| Storage Temperature | T _{STG} | -65 | +150 | |

Absolute maximum electrical ratings are at T_A = 25°C.

Absolute maximum ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

1.5 Electrical Characteristics

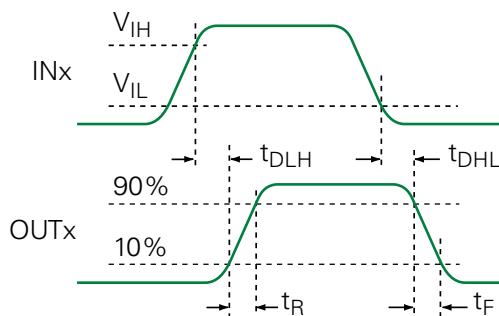
$V_{CC} = 12V$, $T_J = -40^{\circ}C$ to $+125^{\circ}C$, unless otherwise noted.

| Parameter | Conditions | Symbol | Value | | | Units |
|--|--|--------------|---------|---------|---------|----------|
| | | | Minimum | Typical | Maximum | |
| Supply | | | | | | |
| Supply current | OUTA and OUTB open | I_{CC} | - | 1.4 | 2.5 | mA |
| Under Voltage Lockout (UVLO) | | | | | | |
| UVLO Rising Threshold | V_{CC} Rising | $UVLO_{ON}$ | 3.5 | 3.85 | 4.2 | V |
| UVLO Falling Threshold | V_{CC} Falling | $UVLO_{OFF}$ | 3.1 | 3.3 | 3.5 | |
| UVLO Threshold Hysteresis | - | $UVLO_{HYS}$ | 0.2 | 0.5 | 0.8 | |
| Logic Inputs (INA, INB, ENA, ENB) | | | | | | |
| Input Low Voltage | - | V_{IL} | - | - | 0.8 | V |
| Input High Voltage | - | V_{IH} | 2.5 | - | - | |
| Output Drivers (OUTA, OUTB) | | | | | | |
| Output Pull-Up Resistance | $I_{OUT} = -100mA$, $T_J = 25^{\circ}C$ | R_{OH} | - | 1 | 1.5 | Ω |
| | $I_{OUT} = -100mA$ | | - | 1.3 | 1.8 | |
| Output Pull-Down Resistance | $I_{OUT} = 100mA$, $T_J = 25^{\circ}C$ | R_{OL} | - | 0.6 | 1.1 | |
| | $I_{OUT} = 100mA$ | | - | 0.8 | 1.4 | |

1.6 Switching Characteristics

Unless otherwise noted, $V_{CC} = 12V$, $T_J = -40^{\circ}C$ to $+125^{\circ}C$.

| Parameter | Conditions | Symbol | Value | | | Units |
|-------------------|--------------------|-----------|---------|---------|---------|-------|
| | | | Minimum | Typical | Maximum | |
| Propagation delay | $C_{LOAD} = 1.8nF$ | | | | | ns |
| | | t_{DLH} | 5 | 16 | 30 | |
| | t_{DHL} | 5 | 16 | 30 | | |
| Matching | - | - | -5 | - | 5 | |
| Rise Time | $C_{LOAD} = 1.8nF$ | t_R | - | 7 | 15 | |
| Fall Time | $C_{LOAD} = 1.8nF$ | t_F | - | 7 | 15 | |

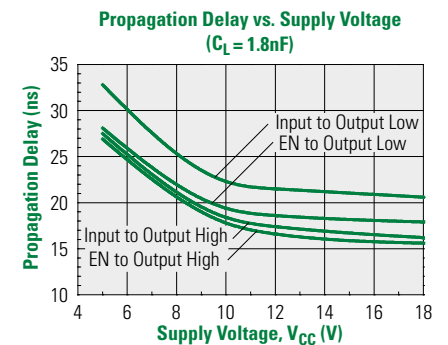
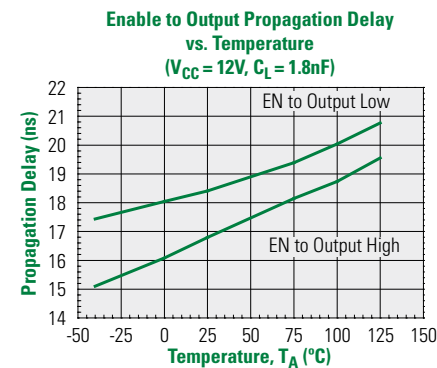
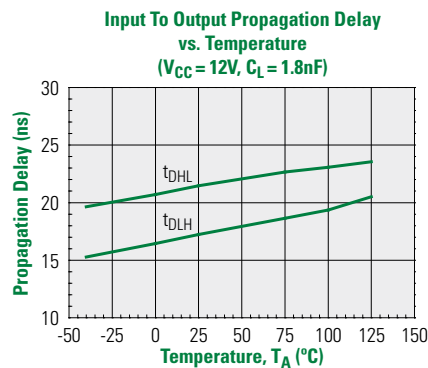
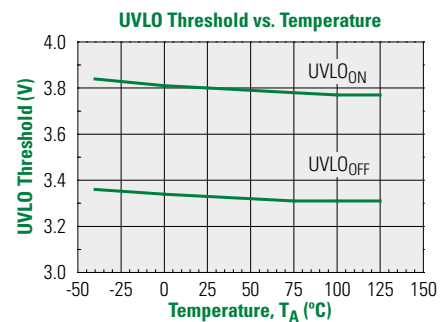
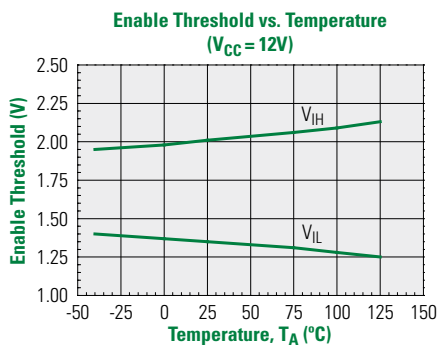
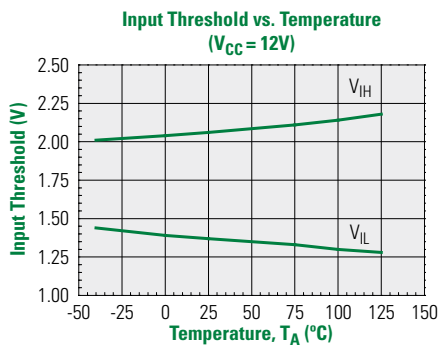
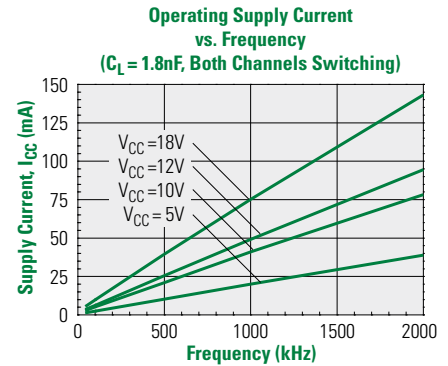
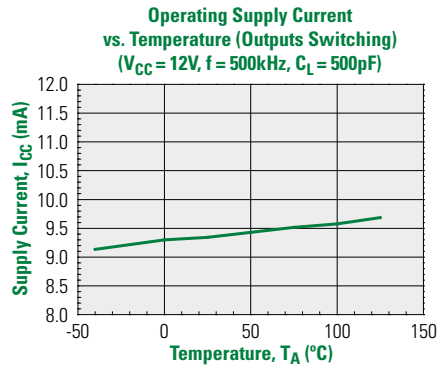
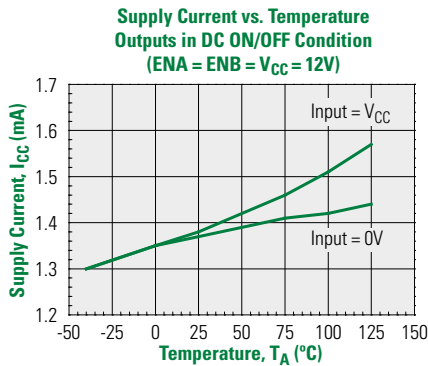


1.7 Thermal Characteristics

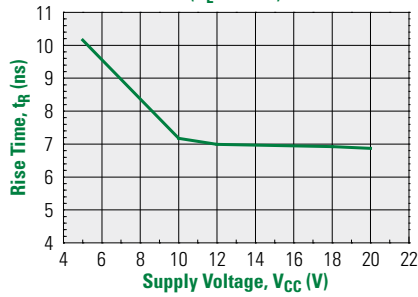
| Parameter | Symbol | Rating | Units |
|---|---------------|--------|---------------|
| IX4340N Thermal Impedance, Junction-to-Ambient | θ_{JA} | 120 | $^{\circ}C/W$ |
| IX4340NE Thermal Impedance, Junction-to-Ambient | θ_{JA} | 85 | |
| IX4340NE Thermal Impedance, Junction-to-Case | θ_{JC} | 10 | |
| IX4340UE Thermal Impedance, Junction-to-Ambient | θ_{JA} | 40 | |
| IX4340UE Thermal Impedance, Junction-to-Case | θ_{JC} | 10 | |

2 Performance Data

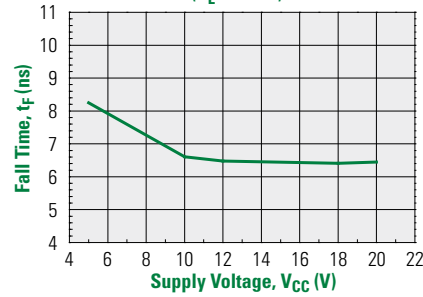
Unless otherwise noted, data presented in these graphs is typical of device operation at $T_A = 25^\circ\text{C}$.



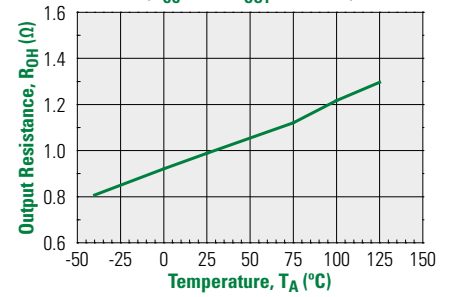
Rise Time vs. Supply Voltage
($C_L = 1.8\text{nF}$)



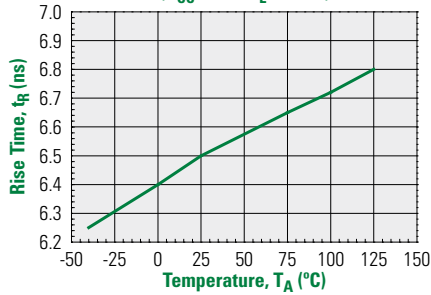
Fall Time vs. Supply Voltage
($C_L = 1.8\text{nF}$)



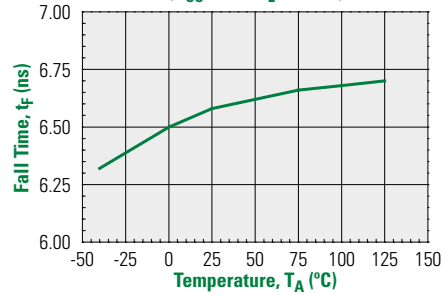
Output Pull-Up Resistance vs. Temperature
($V_{CC} = 12\text{V}$, $I_{OUT} = -100\text{mA}$)



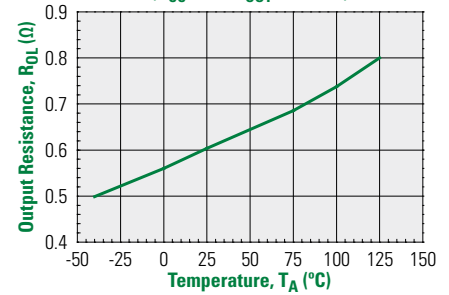
Rise Time vs. Temperature
($V_{CC} = 12\text{V}$, $C_L = 1.8\text{nF}$)



Fall Time vs. Temperature
($V_{CC} = 12\text{V}$, $C_L = 1.8\text{nF}$)



Output Pull-Down Resistance vs. Temperature
($V_{CC} = 12\text{V}$, $I_{OUT} = 100\text{mA}$)



3 Manufacturing Information

3.1 Moisture Sensitivity



All plastic encapsulated semiconductor packages are susceptible to moisture ingress. Littelfuse classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL)** classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

| Device | Moisture Sensitivity Level (MSL) Classification |
|--------------|---|
| All Versions | MSL 1 |

3.2 ESD Sensitivity



This product is **ESD Sensitive**, and should be handled according to the industry standard **JESD-625**.

3.3 Soldering Profile

Provided in the table below is the Classification Temperature (T_C) of this product and the maximum dwell time the body temperature of this device may be ($T_C - 5$)°C or greater. The classification temperature sets the Maximum Body Temperature allowed for this device during lead-free reflow processes. For through-hole devices, and any other processes, the guidelines of **J-STD-020** must be observed.

| Device | Classification Temperature (T_C) | Dwell Time (T_P) | Max Reflow Cycles |
|--------------|--------------------------------------|----------------------|-------------------|
| All Versions | 260°C | 30 seconds | 3 |

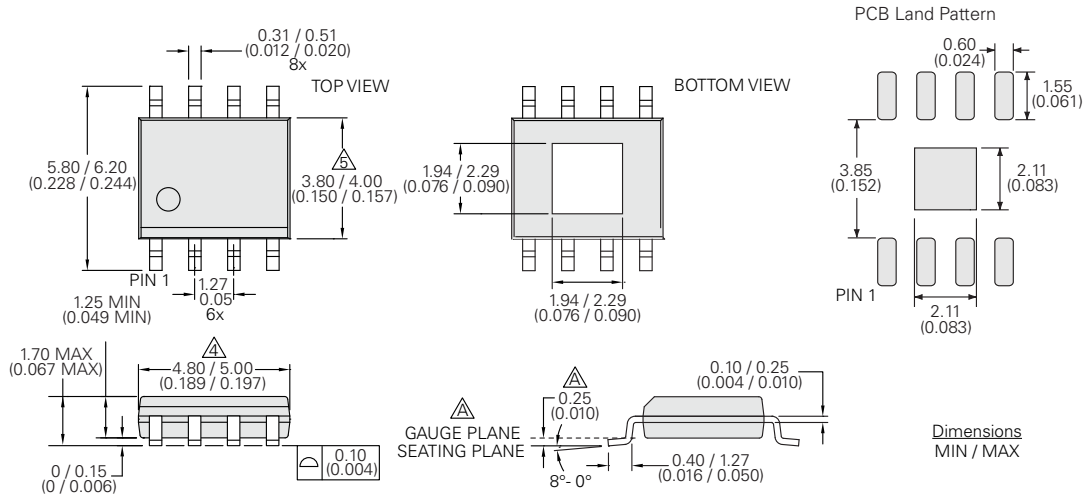
3.4 Board Wash

Littelfuse recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to flux or solvents that are Chlorine-based or Fluorine-based.



3.5 Mechanical Dimensions

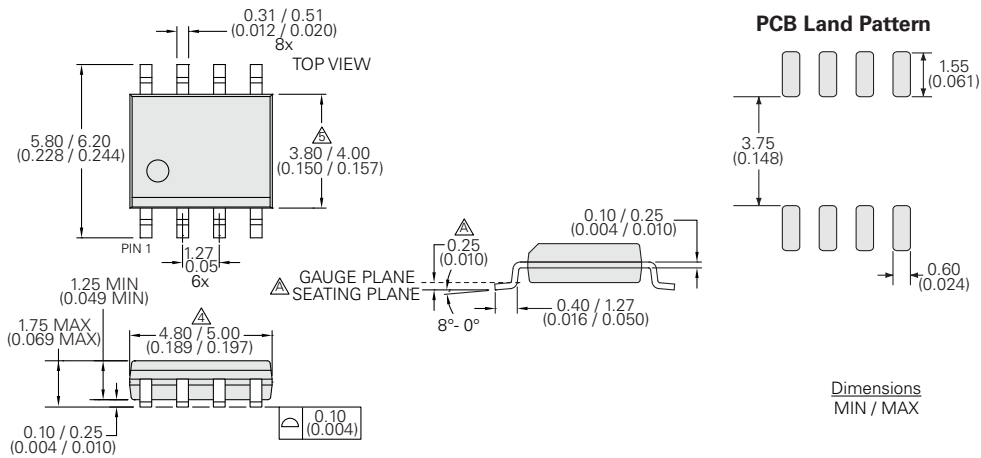
3.5.1 IX4340NE Package Dimensions



Notes:

1. Controlling dimension: millimeters.
2. All dimensions are in mm (inches).
3. This package conforms to JEDEC Standard MS-012, variation BA, Rev. F.
4. Dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15mm per end.
5. Dimension does not include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25mm per side.
6. Lead thickness includes plating.
7. The thermal pad on the bottom of the device may be connected to GND or left floating; it must not be connected to any other signal. The thermal pad is not intended to carry current.

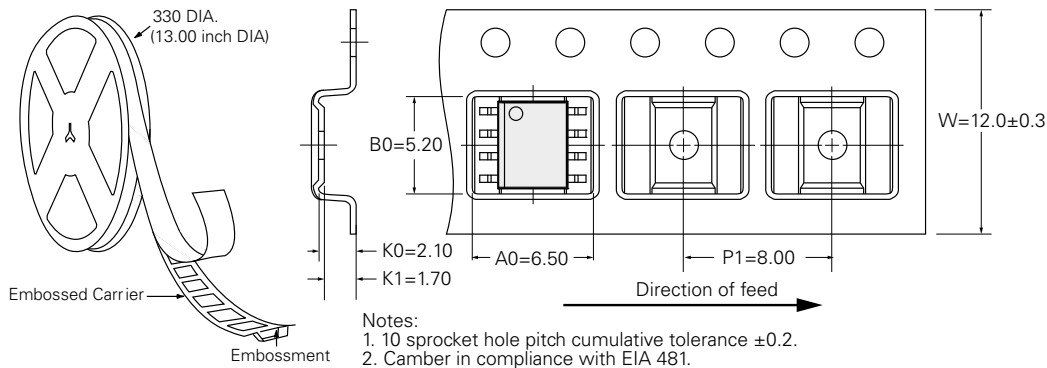
3.5.2 IX4340N Package Dimensions



Notes:

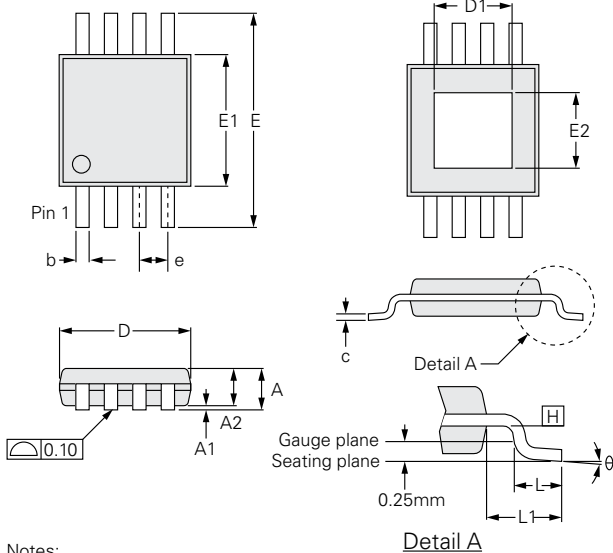
1. Controlling dimension: millimeters.
2. All dimensions are in mm (inches).
3. This package conforms to JEDEC Standard MS-012, variation AA, Rev. F.
4. Dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15mm per end.
5. Dimension does not include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25mm per side.
6. Lead thickness includes plating.

3.5.3 IX4340NTR & IX4340NETR Tape & Reel Dimensions



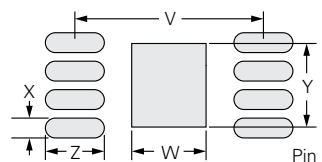
- Notes:
1. 10 sprocket hole pitch cumulative tolerance ± 0.2 .
 2. Camber in compliance with EIA 481.
 3. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.
 4. All dimensions in millimeters.

3.5.4 IX4340UE Package Dimensions



| | MILLIMETERS | | | INCHES | | |
|--------------|-------------|------|------|-----------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | - | - | 1.10 | - | - | 0.043 |
| A1 | 0.00 | - | 0.15 | 0.00 | - | 0.006 |
| A2 | 0.75 | 0.85 | 0.95 | 0.030 | 0.033 | 0.037 |
| b | 0.22 | - | 0.38 | 0.009 | - | 0.015 |
| c | 0.08 | - | 0.23 | 0.003 | - | 0.009 |
| D | 3.00 BSC | | | 0.118 BSC | | |
| D1 | 1.42 | - | 1.93 | 0.056 | - | 0.076 |
| E | 4.90 BSC | | | 0.193 BSC | | |
| E1 | 3.00 BSC | | | 0.118 BSC | | |
| E2 | 1.38 | - | 1.73 | 0.054 | - | 0.068 |
| e | 0.65 BSC | | | 0.026 BSC | | |
| L | 0.40 | 0.60 | 0.80 | 0.016 | 0.024 | 0.031 |
| L1 | 0.95 REF | | | 0.037 REF | | |
| θ | 0° | - | 8° | 0° | - | 8° |
| LAND PATTERN | | | | | | |
| V | - | 4.30 | - | - | 0.169 | - |
| W | - | 1.70 | - | - | 0.067 | - |
| X | - | 0.45 | - | - | 0.018 | - |
| Y | - | 1.90 | - | - | 0.075 | - |
| Z | - | 1.35 | - | - | 0.053 | - |

Recommended PCB Land Pattern



- Notes:
1. Controlling dimension: millimeters.
 2. JEDEC outline: Thermally enhanced: MO-187 AA-T.
 3. Dimension D does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per end.
 4. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.08mm total in excess of the "b" dimension at maximum material condition. The dambar cannot be located on the lower radius of the foot. Minimum space between protrusion and an adjacent lead shall not be less than 0.07mm.
 5. D and E1 dimensions are determined at datum [H].
 6. Lead thickness includes plating.
 7. The thermal pad on the bottom of the device may be connected to GND or left floating; it must not be connected to any other signal. The thermal pad is not intended to carry current.

